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From: tero.m.lehtinen@nokia.com [mailto:tero.m.lehtinen@nokia.com]

Sent: Monday, November 10, 2003 5:18 AM

To: dward@atcb.com

Cc: tero.m.lehtinen@nokia.com

Subject: RE: PYANHL-9_ATCB000853

Hi

[Here is our explanation of EIRP variance.](#)

The device was set to maximum power level for SAR measurements.

The output power levels shown in the SAR report are from the first radiated power measurement, which were erroneous. The power levels remeasured by the EMC lab are valid also for the SAR evaluation.

The EIRP was measured during EMC testing and was not repeated during SAR measurements because the SAR lab is not able to measure radiated power. The product was not reconfigured between EMC and SAR tests and was carefully packed for transportation between the test labs. The power settings are stored in digital memory and were the same for EMC and SAR tests.

BR Tero Lehtinen